

Applicat	ion/Control	No.

Applicant(s)/Patent under Reexamination
NAGANO ET AL.

10/807,426

Art Unit

Examiner

Ana L. Woodward

1711

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/807,426	NAGANO ET AL.	
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